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Sheet 1 of 1	
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U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	EP	6,180,167	1/30/2001	Majewski et al.	—	—
2.	EP	6,371,489	4/16/2002	Combet et al.	—	—
3.	EP	6,499,743	12/31/2002	Sadowski	—	—
4.	EP	6,722,662	4/20/2004	Heilig et al.	—	—

FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	Translation No
1.	EP	EP 0 757 195 B1	6/7/2000	Europe	—	Abstract	
2.	EP	EP 0 769 616 B1	11/8/2000	Europe	—	Abstract	
3.	EP	EP 0 816 723 B1	9/25/2002	Europe	—	Abstract (see also USPN 6180167)	
4.	EP	EP 0 915 271 B1	12/3/2003	Europe	—	Abstract	
5.	EP	EP 0 915 272 B1	12/3/2003	Europe	—	Abstract	
6.	EP	EP 1 099 891 B1	11/19/2003	Europe	—	Abstract	
7.	EP	EP 1 271 016 B1	3/17/2004	Europe	—	Abstract	
8.	EP	WO 01/02714 A1	1/11/2001	PCT	—	X	
9.	EP	WO 02/079630 A1	10/10/2002	PCT	—	X	

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3/30/05

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